

# Low Temperature Top Seal for the LAPPD Project

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# Direction of Seal Development

- There are two main directions
- Direction #1 Solder type seal
- Direction #2 Compression Seal

# Soldering Technical Information

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- In52/Sn48 alloy has a m.p. of 118° C.
- In66/Bi34 alloy has a m.p. of 72° C.
- Vacuum soldering:  $10^{-6}$  Torr.
- After soldering tests, samples were leak tested to evaluate sealing quality.
- No pressure was applied during bonding.

# Solder

## Preliminary Leak Test Results

Filler Alloy (thickness)	Sidewall	Window	Temperature	Leak Test, std. cc/s He
In52/Sn48 (50µm x 2)	Ag	Ag	127	Background: $10^{-8}$ Max Leak: $10^{-7}$
			127	Background: $6.3 \times 10^{-8}$ Max Leak: leak
	Ag	NiCr	128	Background: $2.0 \times 10^{-9}$ Max Leak: $2.3 \times 10^{-7}$
	NiCr	NiCr	126	Background: $2.6 \times 10^{-9}$ (*) Max Leak: $7.5 \times 10^{-8}$
			129	Background: $1.5 \times 10^{-8}$ Max Leak: $2.0 \times 10^{-7}$
			128	Background: $8.5 \times 10^{-10}$ Max Leak: $2.0 \times 10^{-8}$
	Glass	Ag	127	Background: $2 \times 10^{-9}$ (*) Max Leak: $3 \times 10^{-7}$
	Glass	Glass	127	Background: $2 \times 10^{-9}$ (*) Max Leak: $2.3 \times 10^{-7}$
66In/34Bi (100µm)	Ag	Ag	76	Background: $6.3 \times 10^{-8}$ Max Leak: Leak
			76	Background: $1.6 \times 10^{-8}$ (*) Max Leak: $10^{-5}$
			75	Background: $1.2 \times 10^{-9}$ Max Leak: $2 \times 10^{-7}$
			75	Background: $2.4 \times 10^{-9}$ Max Leak: $1 \times 10^{-6}$

- General Baseline:  $8 \times 10^{-10}$  std. cc/s Helium
- (\*) Baseline may have been closer to  $1.5 \times 10^{-9}$
- NiCr layer is approx. 20 nm thick.

# Solder

## Appearance of Silver Layer



- 66In/34Bi
- Formation of discolored patches at silver-glass interface.
- Intermetallics? Oxides?



- 52In/48Sn
- Lesser formation of discolored patches.
- Intermetallics? Oxides?



# Solder

## Preliminary Conclusions

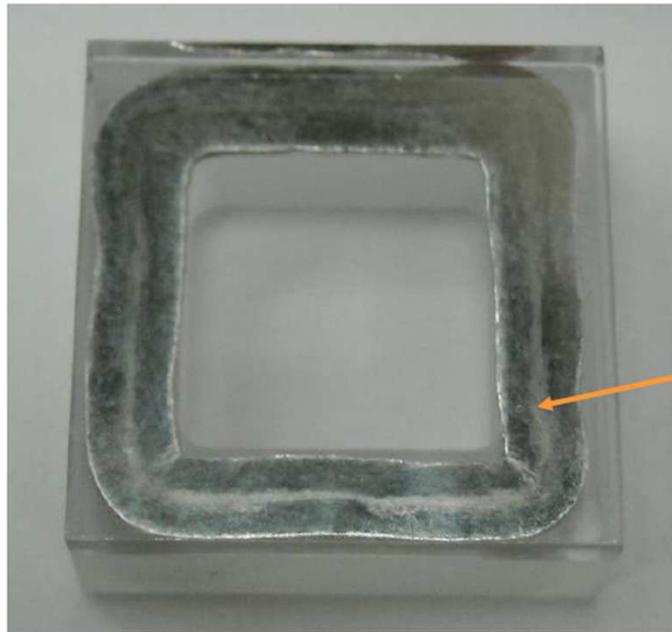
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- Samples with NiCr coatings had better leak test results than those with Ag layers.
- 66In/34Bi foil produced more discolored patches than 52In/48Sn at the silver paste layer-glass interface.
  - The composition and relevance of these patches are not yet determined
- Samples will be leak checked again in the future to determine effects of aging.

# Compression Seal

## Wire Seals

- Plastic deformation is key
- 100%In wire - 0.030" D



Area of indium oxide showing the original location of the wire.

# Compression Seal

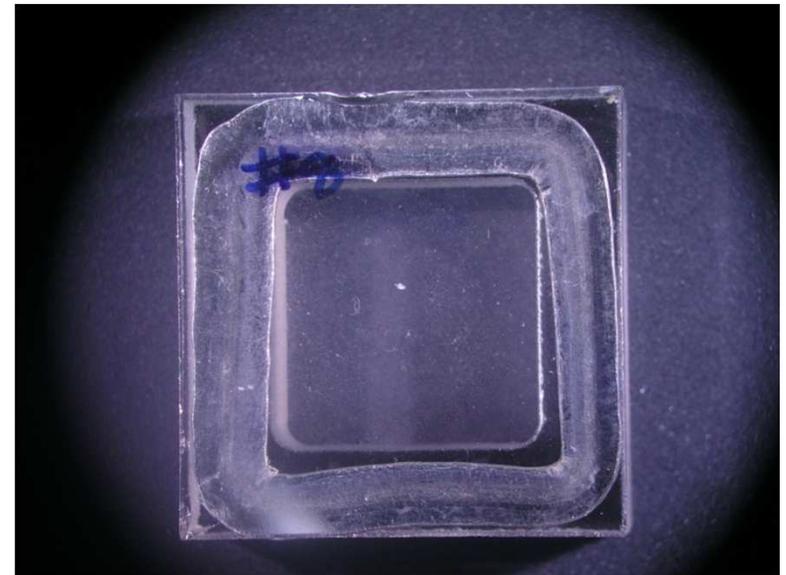
## 3.B. Thermocompression tests (\*)

Indium alloy	Temperature, °C	Force, lbs	Time, min	Comments	Leaking test,
Pure indium wire	~ 30	700	10	Good deformation	Background: $< 1.0 \times 10^{-10}$ Leak at wire overlap
		800		Good deformation	Background: $< 1.0 \times 10^{-10}$ Leak at wire overlap
		800		Good deformation	Background: $< 1.0 \times 10^{-10}$ Leak at wire overlap
	~ 40	800	10	Partial deformation	Background: $< 1.0 \times 10^{-10}$ No Leak
		800		Partial deformation	Did not pump down
		1000		Good deformation	Background: $5.0 \times 10^{-10}$

# Recent Successes with a compression seal

## 1 inch Sample Parts

- With a loading of 800 lbs, seals have been made between both glass and NiCr coated glass substrates.
- The seal filler was pure indium in the form of .062" diameter wire
- These seals were made in air.
- All the parts were cleaned in acetone and alcohol.
- At loads of 600 lbs and lower the joint between the ends of the wire became a problem.
  - Although there is evidence that a seal was made at loads as low as 300 lbs .



800 lbs – 100 In – 20°C – 1 minute

# Equipment Progress

- Low Temperature Bonding System
  - Now operational for heating
    - Heating controls completed by HEP Electronics
    - Infrared lamps operational in the system.
  - Vacuum system
    - System leak tight
    - Base pressure of the system is  $3 \times 10^{-8}$  torr.
  - Hydraulics
    - Last parts being completed in shops
    - Hydraulic manifold leak tight and ready to move onto the system.



# Future Plans

- Investigate the reduction and removal of the oxide layer on filler material and the substrate coatings.
- Continue to try tests of wire joints.
- Look at a other coating materials such as: chromium and aluminum
- Start to do the tests in the in vacuum rather than in air.
  
- Continue to pursue the soldering method
  - The system above has a heating capability to perform soldering in vacuum
- Fab samples that do not use flat surface to compress the seal, these samples will use beveled edges. It will be investigated that by applying the load in a small area improves the seal performance.

